

FEATURES

Latch-up proof
 3 pF off source capacitance
 5 pF off drain capacitance
 0.07 pC charge injection
 Low leakage: 0.2 nA maximum at 85°C
 ±9 V to ±22 V dual-supply operation
 9 V to 40 V single-supply operation
 48 V supply maximum ratings
 Fully specified at ±15 V, ±20 V, +12 V, and +36 V
 V_{SS} to V_{DD} analog signal range

APPLICATIONS

Automatic test equipment
 Data acquisition
 Instrumentation
 Avionics
 Audio and video switching
 Communication systems

GENERAL DESCRIPTION

The [ADG5212/ADG5213](#) contain four independent single-pole/single-throw (SPST) switches. The [ADG5212](#) switches turn on with Logic 1. The [ADG5213](#) has two switches with digital control logic similar to that of the [ADG5212](#); however, the logic is inverted on the other two switches. Each switch conducts equally well in both directions when on, and each switch has an input signal range that extends to the supplies. In the off condition, signal levels up to the supplies are blocked.

The [ADG5212](#) and [ADG5213](#) do not have a V_L pin. The digital inputs are compatible with 3 V logic inputs over the full operating supply range.

The ultralow capacitance and charge injection of these switches make them ideal solutions for data acquisition and sample-and-hold applications, where low glitch and fast settling are required. Fast switching speed together with high signal bandwidth make the parts suitable for video signal switching.

FUNCTIONAL BLOCK DIAGRAMS

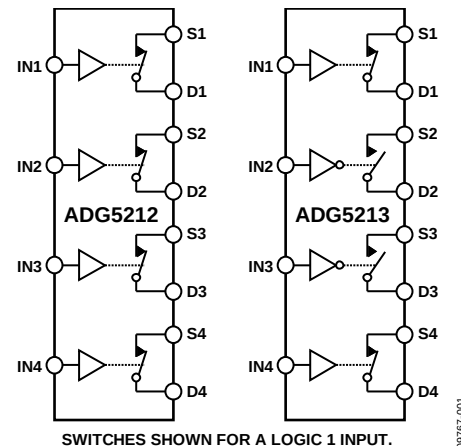


Figure 1.

PRODUCT HIGHLIGHTS

1. Trench Isolation Guards Against Latch-Up.
A dielectric trench separates the P and N channel transistors, thereby preventing latch-up even under severe overvoltage conditions.
2. Ultralow Capacitance and <1 pC Charge Injection.
3. Dual-Supply Operation.
For applications where the analog signal is bipolar, the [ADG5212/ADG5213](#) can be operated from dual supplies of up to ±22 V.
4. Single-Supply Operation.
For applications where the analog signal is unipolar, the [ADG5212/ADG5213](#) can be operated from a single rail power supply of up to 40 V.
5. 3 V Logic-Compatible Digital Inputs.
 $V_{INH} = 2.0$ V, $V_{INL} = 0.8$ V.
6. No V_L Logic Power Supply Required.

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REVISION HISTORY

9/15—Rev. 0 to Rev. A

Changed Off Isolation Parameter from –105 dB Typical at 25°C to –80 dB Typical at 25°C	Throughout
Change to Applications Information Section	18
Change to Figure 34 Caption	19
Changes to Ordering Guide	19

4/11—Revision 0: Initial Version

SPECIFICATIONS

±15 V DUAL SUPPLY

$V_{DD} = +15\text{ V} \pm 10\%$, $V_{SS} = -15\text{ V} \pm 10\%$, GND = 0 V, unless otherwise noted.

Table 1.

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			V_{DD} to V_{SS}	V max	$V_S = \pm 10\text{ V}$, $I_S = -1\text{ mA}$, see Figure 24
On Resistance, R_{ON}	160			Ω typ	
	200	250	280	Ω max	$V_{DD} = +13.5\text{ V}$, $V_{SS} = -13.5\text{ V}$
On-Resistance Match Between Channels, ΔR_{ON}	2			Ω typ	$V_S = \pm 10\text{ V}$, $I_S = -1\text{ mA}$
	8	9	10	Ω max	
On-Resistance Flatness, $R_{FLAT(ON)}$	38			Ω typ	$V_S = \pm 10\text{ V}$, $I_S = -1\text{ mA}$
	50	65	70	Ω max	
LEAKAGE CURRENTS					
Source Off Leakage, I_S (Off)	0.01			nA typ	$V_{DD} = +16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ $V_S = \pm 10\text{ V}$, $V_D = \mp 10\text{ V}$, see Figure 23
	0.1	0.2	0.4	nA max	
Drain Off Leakage, I_D (Off)	0.01			nA typ	$V_S = \pm 10\text{ V}$, $V_D = \mp 10\text{ V}$, see Figure 23
	0.1	0.2	0.4	nA max	
Channel On Leakage, I_D (On), I_S (On)	0.02			nA typ	$V_S = V_D = \pm 10\text{ V}$, see Figure 26
	0.2	0.25	0.9	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	$V_{IN} = V_{GND}$ or V_{DD}
Input Low Voltage, V_{INL}			0.8	V max	
Input Current, I_{INL} or I_{INH}	0.002		± 0.1	μA typ	
				μA max	
Digital Input Capacitance, C_{IN}	3			pF typ	
DYNAMIC CHARACTERISTICS¹					
t_{ON}	175			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	210	255	280	ns max	$V_S = 10\text{ V}$, see Figure 30
t_{OFF}	140			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	170	195	215	ns max	$V_S = 10\text{ V}$, see Figure 30
Break-Before-Make Time Delay, t_D (ADG5213 Only)	40			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
			20	ns min	$V_{S1} = V_{S2} = 10\text{ V}$, see Figure 29
Charge Injection, Q_{INU}	0.07			pC typ	$V_S = 0\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$, see Figure 31
Off Isolation	−80			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$, see Figure 25
Channel-to-Channel Crosstalk	−105			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$, see Figure 27
−3 dB Bandwidth	435			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, see Figure 28
Insertion Loss	−6.8			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$, see Figure 28
C_S (Off)	3			pF typ	$V_S = 0\text{ V}$, $f = 1\text{ MHz}$
C_D (Off)	5			pF typ	$V_S = 0\text{ V}$, $f = 1\text{ MHz}$
C_D (On), C_S (On)	8			pF typ	$V_S = 0\text{ V}$, $f = 1\text{ MHz}$
POWER REQUIREMENTS					
I_{DD}	45			μA typ	$V_{DD} = +16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ Digital inputs = 0 V or V_{DD}
	55		70	μA max	
I_{SS}	0.001			μA typ	Digital inputs = 0 V or V_{DD}
			1	μA max	
V_{DD}/V_{SS}			$\pm 9/\pm 22$	V min/V max	GND = 0 V

¹ Guaranteed by design; not subject to production test.

±20 V DUAL SUPPLY

$V_{DD} = +20\text{ V} \pm 10\%$, $V_{SS} = -20\text{ V} \pm 10\%$, GND = 0 V, unless otherwise noted.

Table 2.

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			V _{DD} to V _{SS}	V max	V _S = ±15 V, I _S = −1 mA, see Figure 24 V _{DD} = +18 V, V _{SS} = −18 V V _S = ±15 V, I _S = −1 mA
On Resistance, R _{ON}	140			Ω typ	
On-Resistance Match Between Channels, ΔR _{ON}	160 1.5	200	230	Ω max Ω typ	
On-Resistance Flatness, R _{FLAT(ON)}	8 33 45	9 55	10 60	Ω max Ω typ Ω max	
LEAKAGE CURRENTS					
Source Off Leakage, I _S (Off)	0.01			nA typ	V _{DD} = +22 V, V _{SS} = −22 V V _S = ±15 V, V _D = ∓15 V, see Figure 23
Drain Off Leakage, I _D (Off)	0.1 0.01	0.2	0.4	nA max nA typ	V _S = ±15 V, V _D = ∓15 V, see Figure 23
Channel On Leakage, I _D (On), I _S (On)	0.1 0.02 0.2	0.2 0.25	0.4 0.9	nA max nA typ nA max	
DIGITAL INPUTS					
Input High Voltage, V _{INH}			2.0	V min	V _{IN} = V _{GND} or V _{DD}
Input Low Voltage, V _{INL}			0.8	V max	
Input Current, I _{INL} or I _{INH}	0.002		±0.1	μA typ μA max	
Digital Input Capacitance, C _{IN}	3			pF typ	
DYNAMIC CHARACTERISTICS ¹					
t _{ON}	155 195	235	255	ns typ ns max	R _L = 300 Ω, C _L = 35 pF V _S = 10 V, see Figure 30
t _{OFF}	145 165			ns typ ns max	
Break-Before-Make Time Delay, t _D (ADG5213 Only)	35			ns typ	R _L = 300 Ω, C _L = 35 pF
Charge Injection, Q _{INJ}	−0.5		20	ns min pC typ	V _{S1} = V _{S2} = 10 V, see Figure 29 V _S = 0 V, R _S = 0 Ω, C _L = 1 nF, see Figure 31
Off Isolation	−80			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz, see Figure 25
Channel-to-Channel Crosstalk	−105			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz, see Figure 27
−3 dB Bandwidth	460			MHz typ	R _L = 50 Ω, C _L = 5 pF, see Figure 28
Insertion Loss	−6			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz, see Figure 28
C _S (Off)	2.8			pF typ	V _S = 0 V, f = 1 MHz
C _D (Off)	4.8			pF typ	V _S = 0 V, f = 1 MHz
C _D (On), C _S (On)	8			pF typ	V _S = 0 V, f = 1 MHz

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
POWER REQUIREMENTS					$V_{DD} = +22\text{ V}$, $V_{SS} = -22\text{ V}$
I_{DD}	50			$\mu\text{A typ}$	Digital inputs = 0 V or V_{DD}
I_{SS}	70		110	$\mu\text{A max}$	
	0.001		1	$\mu\text{A typ}$	Digital inputs = 0 V or V_{DD}
V_{DD}/V_{SS}			$\pm 9/\pm 22$	$\mu\text{A max}$ V min/V max	GND = 0 V

¹ Guaranteed by design; not subject to production test.

12 V SINGLE SUPPLY

$V_{DD} = 12\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, GND = 0 V, unless otherwise noted.

Table 3.

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V_{DD}	V max	
On Resistance, R_{ON}	350			$\Omega\text{ typ}$	$V_S = 0\text{ V to }10\text{ V}$, $I_S = -1\text{ mA}$, see Figure 24
	500	610	700	$\Omega\text{ max}$	$V_{DD} = 10.8\text{ V}$, $V_{SS} = 0\text{ V}$
On-Resistance Match Between Channels, ΔR_{ON}	4			$\Omega\text{ typ}$	$V_S = 0\text{ V to }10\text{ V}$, $I_S = -1\text{ mA}$
	20	21	22	$\Omega\text{ max}$	
On-Resistance Flatness, $R_{FLAT(ON)}$	160			$\Omega\text{ typ}$	$V_S = 0\text{ V to }10\text{ V}$, $I_S = -1\text{ mA}$
	280	335	370	$\Omega\text{ max}$	
LEAKAGE CURRENTS					$V_{DD} = 13.2\text{ V}$, $V_{SS} = 0\text{ V}$
Source Off Leakage, I_S (Off)	0.01			nA typ	$V_S = 1\text{ V}/10\text{ V}$, $V_D = 10\text{ V}/1\text{ V}$, see Figure 23
	0.1	0.2	0.4	nA max	
Drain Off Leakage, I_D (Off)	0.01			nA typ	$V_S = 1\text{ V}/10\text{ V}$, $V_D = 10\text{ V}/1\text{ V}$, see Figure 23
	0.1	0.2	0.4	nA max	
Channel On Leakage, I_D (On), I_S (On)	0.02			nA typ	$V_S = V_D = 1\text{ V}/10\text{ V}$, see Figure 26
	0.2	0.25	0.9	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	
Input Low Voltage, V_{INL}			0.8	V max	
Input Current, I_{INL} or I_{INH}	0.002		± 0.1	$\mu\text{A typ}$ $\mu\text{A max}$	$V_{IN} = V_{GND}$ or V_{DD}
Digital Input Capacitance, C_{IN}	3			pF typ	
DYNAMIC CHARACTERISTICS ¹					
t_{ON}	235			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	290	360	410	ns max	$V_S = 8\text{ V}$, see Figure 30
t_{OFF}	165			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	205	235	260	ns max	$V_S = 8\text{ V}$, see Figure 30
Break-Before-Make Time Delay, t_D (ADG5213 Only)	85			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
			50	ns min	$V_{S1} = V_{S2} = 8\text{ V}$, see Figure 29
Charge Injection, Q_{INJ}	−0.5			pC typ	$V_S = 6\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$, see Figure 31
Off Isolation	−80			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$, see Figure 25
Channel-to-Channel Crosstalk	−105			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$, see Figure 27
−3 dB Bandwidth	340			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, see Figure 28

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
Insertion Loss	−11			dB typ	$R_L = 50\ \Omega$, $C_L = 5\ \text{pF}$, $f = 1\ \text{MHz}$, see Figure 28
C_S (Off)	3.5			pF typ	$V_S = 6\ \text{V}$, $f = 1\ \text{MHz}$
C_D (Off)	5.5			pF typ	$V_S = 6\ \text{V}$, $f = 1\ \text{MHz}$
C_D (On), C_S (On)	9			pF typ	$V_S = 6\ \text{V}$, $f = 1\ \text{MHz}$
POWER REQUIREMENTS					
I_{DD}	40		65	μA typ μA max	$V_{DD} = 13.2\ \text{V}$ Digital inputs = 0 V or V_{DD}
V_{DD}			9/40	V min/V max	GND = 0 V, $V_{SS} = 0\ \text{V}$

¹ Guaranteed by design; not subject to production test.

36 V SINGLE SUPPLY

$V_{DD} = 36\ \text{V} \pm 10\%$, $V_{SS} = 0\ \text{V}$, GND = 0 V, unless otherwise noted.

Table 4.

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V_{DD}	V max	
On Resistance, R_{ON}	150			Ω typ	$V_S = 0\ \text{V}$ to 30 V, $I_S = -1\ \text{mA}$, see Figure 24
	170	215	245	Ω max	$V_{DD} = 32.4\ \text{V}$, $V_{SS} = 0\ \text{V}$
On-Resistance Match Between Channels, ΔR_{ON}	1.6			Ω typ	$V_S = 0\ \text{V}$ to 30 V, $I_S = -1\ \text{mA}$
	8	9	10	Ω max	
On-Resistance Flatness, $R_{FLAT(ON)}$	35			Ω typ	$V_S = 0\ \text{V}$ to 30 V, $I_S = -1\ \text{mA}$
	50	60	65	Ω max	
LEAKAGE CURRENTS					
Source Off Leakage, I_S (Off)	0.01			nA typ	$V_{DD} = 39.6\ \text{V}$, $V_{SS} = 0\ \text{V}$ $V_S = 1\ \text{V}/30\ \text{V}$, $V_D = 30\ \text{V}/1\ \text{V}$, see Figure 23
	0.1	0.2	0.4	nA max	
Drain Off Leakage, I_D (Off)	0.01			nA typ	$V_S = 1\ \text{V}/30\ \text{V}$, $V_D = 30\ \text{V}/1\ \text{V}$, see Figure 23
	0.1	0.2	0.4	nA max	
Channel On Leakage, I_D (On), I_S (On)	0.02			nA typ	$V_S = V_D = 1\ \text{V}/30\ \text{V}$, see Figure 26
	0.2	0.25	0.9	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	
Input Low Voltage, V_{INL}			0.8	V max	
Input Current, I_{INL} or I_{INH}	0.002			μA typ	$V_{IN} = V_{GND}$ or V_{DD}
			± 0.1	μA max	
Digital Input Capacitance, C_{IN}	3			pF typ	
DYNAMIC CHARACTERISTICS ¹					
t_{ON}	190			ns typ	$R_L = 300\ \Omega$, $C_L = 35\ \text{pF}$
	230	255	265	ns max	$V_S = 18\ \text{V}$, see Figure 30
t_{OFF}	175			ns typ	$R_L = 300\ \Omega$, $C_L = 35\ \text{pF}$
	215	230	245	ns max	$V_S = 18\ \text{V}$, see Figure 30
Break-Before-Make Time Delay, t_D (ADG5213 Only)	45			ns typ	$R_L = 300\ \Omega$, $C_L = 35\ \text{pF}$
			25	ns min	$V_{S1} = V_{S2} = 18\ \text{V}$, see Figure 29
Charge Injection, Q_{INU}	−0.5			pC typ	$V_S = 18\ \text{V}$, $R_S = 0\ \Omega$, $C_L = 1\ \text{nF}$, see Figure 31
Off Isolation	−80			dB typ	$R_L = 50\ \Omega$, $C_L = 5\ \text{pF}$, $f = 1\ \text{MHz}$, see Figure 25
Channel-to-Channel Crosstalk	−105			dB typ	$R_L = 50\ \Omega$, $C_L = 5\ \text{pF}$, $f = 1\ \text{MHz}$, Figure 27

Parameter	25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
−3 dB Bandwidth	410			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\ \text{pF}$, see Figure 28
Insertion Loss	−6.8			dB typ	$R_L = 50\ \Omega$, $C_L = 5\ \text{pF}$, $f = 1\ \text{MHz}$, see Figure 28
C_S (Off)	3			pF typ	$V_S = 18\ \text{V}$, $f = 1\ \text{MHz}$
C_D (Off)	5			pF typ	$V_S = 18\ \text{V}$, $f = 1\ \text{MHz}$
C_D (On), C_S (On)	8			pF typ	$V_S = 18\ \text{V}$, $f = 1\ \text{MHz}$
POWER REQUIREMENTS					$V_{DD} = 39.6\ \text{V}$
I_{DD}	80		130	μA typ	Digital inputs = 0 V or V_{DD}
	100		9/40	μA max	
V_{DD}				V min/V max	GND = 0 V, $V_{SS} = 0\ \text{V}$

¹ Guaranteed by design; not subject to production test.

CONTINUOUS CURRENT PER CHANNEL, S_x OR D_x

Table 5.

Parameter	25°C	85°C	125°C	Unit
CONTINUOUS CURRENT, S_x or D_x				
$V_{DD} = +15\ \text{V}$, $V_{SS} = -15\ \text{V}$				
TSSOP ($\theta_{JA} = 112.6^\circ\text{C/W}$)	18	10	5	mA maximum
LFCSP ($\theta_{JA} = 30.4^\circ\text{C/W}$)	32	15	6	mA maximum
$V_{DD} = +20\ \text{V}$, $V_{SS} = -20\ \text{V}$				
TSSOP ($\theta_{JA} = 112.6^\circ\text{C/W}$)	29	16	8	mA maximum
LFCSP ($\theta_{JA} = 30.4^\circ\text{C/W}$)	50	22	9	mA maximum
$V_{DD} = 12\ \text{V}$, $V_{SS} = 0\ \text{V}$				
TSSOP ($\theta_{JA} = 112.6^\circ\text{C/W}$)	18	12	7	mA maximum
LFCSP ($\theta_{JA} = 30.4^\circ\text{C/W}$)	32	17	8	mA maximum
$V_{DD} = 36\ \text{V}$, $V_{SS} = 0\ \text{V}$				
TSSOP ($\theta_{JA} = 112.6^\circ\text{C/W}$)	34	18	8	mA maximum
LFCSP ($\theta_{JA} = 30.4^\circ\text{C/W}$)	59	24	9	mA maximum

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted.

Table 6.

Parameter	Rating
V_{DD} to V_{SS}	48 V
V_{DD} to GND	$-0.3\text{ V to }+48\text{ V}$
V_{SS} to GND	$+0.3\text{ V to }-48\text{ V}$
Analog Inputs ¹	$V_{SS} - 0.3\text{ V to }V_{DD} + 0.3\text{ V}$ or 30 mA, whichever occurs first
Digital Inputs ¹	$V_{SS} - 0.3\text{ V to }V_{DD} + 0.3\text{ V}$ or 30 mA, whichever occurs first
Peak Current, Sx or Dx Pin	60 mA (pulsed at 1 ms, 10% duty cycle maximum)
Continuous Current, Sx or Dx ²	Data + 15%
Temperature	
Operating Range	$-40^\circ\text{C to }+125^\circ\text{C}$
Storage Range	$-65^\circ\text{C to }+150^\circ\text{C}$
Junction	150°C
Thermal Impedance, θ_{JA}	
16-Lead TSSOP (4-Layer Board)	112.6°C/W
16-Lead LFCSP (4-Layer Board)	30.4°C/W
Reflow Soldering Peak Temperature, Pb Free	$260(+0/-5)^\circ\text{C}$

¹ Overvoltages at the INx, Sx, and Dx pins are clamped by internal diodes.
Limit current to the maximum ratings given.

² See Table 5.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Only one absolute maximum rating can be applied at any one time.

ESD CAUTION



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

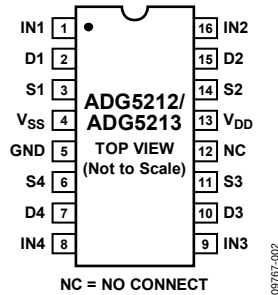
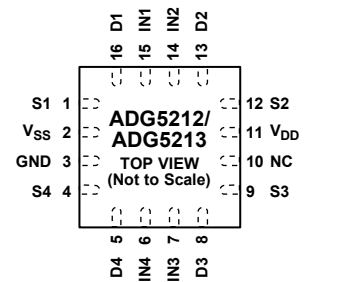


Figure 2. TSSOP Pin Configuration



NOTES
 1. EXPOSED PAD TIED TO SUBSTRATE, V_{SS} .
 2. NC = NO CONNECT.

Figure 3. LFCSP Pin Configuration

Table 7. Pin Function Descriptions

Pin No.		Mnemonic	Description
TSSOP	LFCSP		
1	15	IN1	Logic Control Input.
2	16	D1	Drain Terminal. This pin can be an input or an output.
3	1	S1	Source Terminal. This pin can be an input or an output.
4	2	V_{SS}	Most Negative Power Supply Potential.
5	3	GND	Ground (0 V) Reference.
6	4	S4	Source Terminal. This pin can be an input or an output.
7	5	D4	Drain Terminal. This pin can be an input or an output.
8	6	IN4	Logic Control Input.
9	7	IN3	Logic Control Input.
10	8	D3	Drain Terminal. This pin can be an input or an output.
11	9	S3	Source Terminal. This pin can be an input or an output.
12	10	NC	No Connect. These pins are open.
13	11	V_{DD}	Most Positive Power Supply Potential.
14	12	S2	Source Terminal. This pin can be an input or an output.
15	13	D2	Drain Terminal. This pin can be an input or an output.
16	14	IN2	Logic Control Input.
N/A ¹	EP	Exposed pad	Exposed Pad. The exposed pad is connected internally. For increased reliability of the solder joints and maximum thermal capability, it is recommended that the pad be soldered to the substrate, V_{SS} .

¹ N/A means not applicable.

Table 8. ADG5212 Truth Table

ADG5212 INx	Switch Condition
1	On
0	Off

Table 9. ADG5213 Truth Table

ADG5213 INx	S1, S4	S2, S3
0	Off	On
1	On	Off

TYPICAL PERFORMANCE CHARACTERISTICS

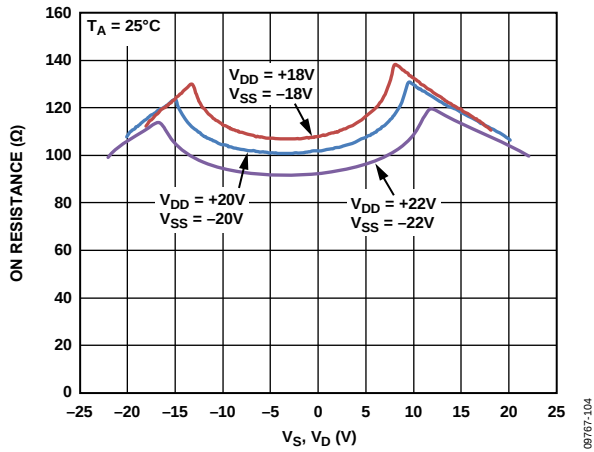


Figure 4. R_{ON} as a Function of V_S , V_D (Dual Supply)

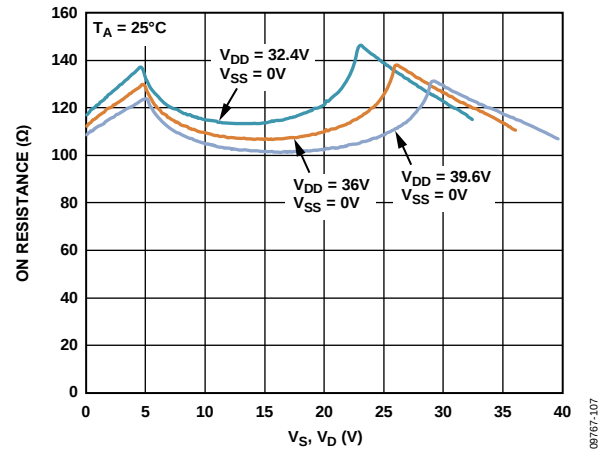


Figure 7. R_{ON} as a Function of V_S , V_D (Single Supply)

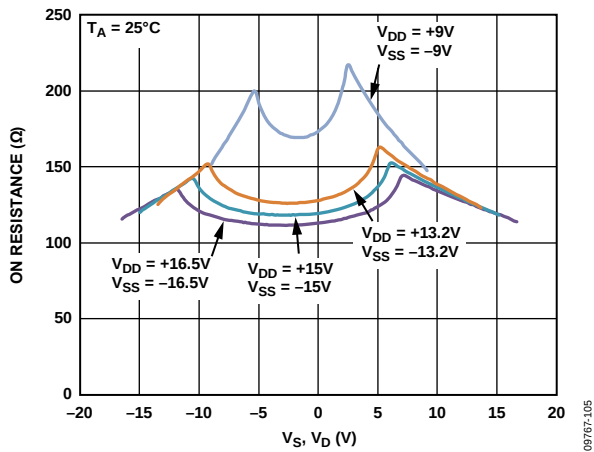


Figure 5. R_{ON} as a Function of V_S , V_D (Dual Supply)

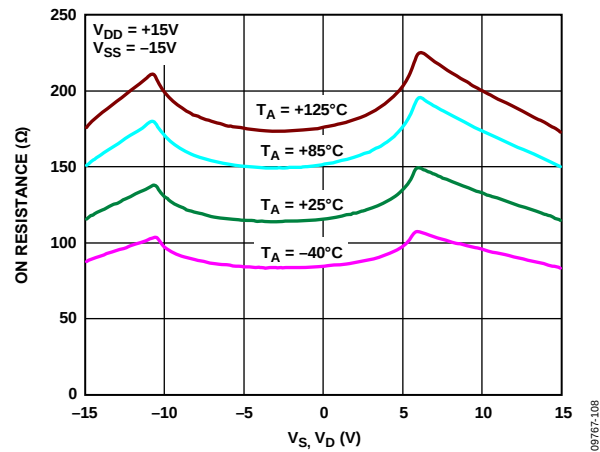


Figure 8. R_{ON} as a Function of V_S , V_D for Different Temperatures, ± 15 V Dual Supply

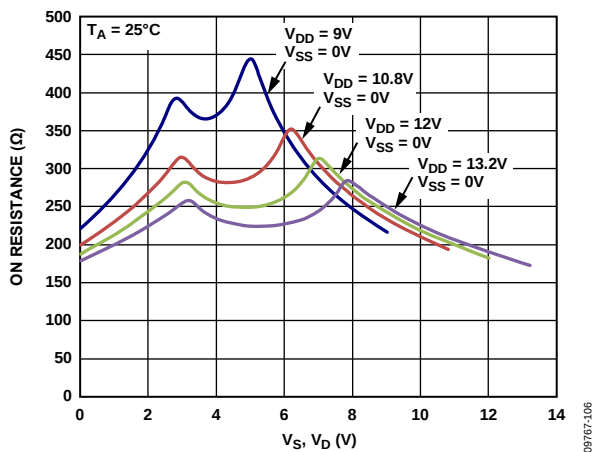


Figure 6. R_{ON} as a Function of V_S , V_D (Single Supply)

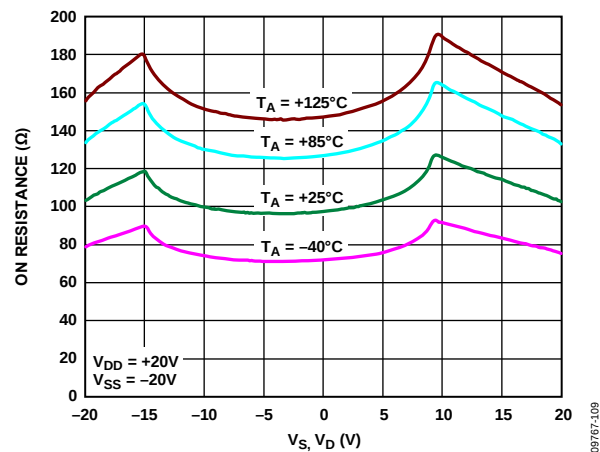


Figure 9. R_{ON} as a Function of V_S , V_D for Different Temperatures, ± 20 V Dual Supply

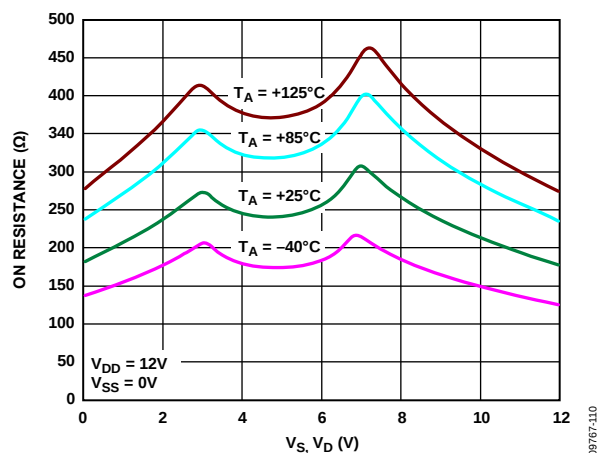


Figure 10. R_{ON} as a Function of V_S , V_D for Different Temperatures, 12 V Single Supply

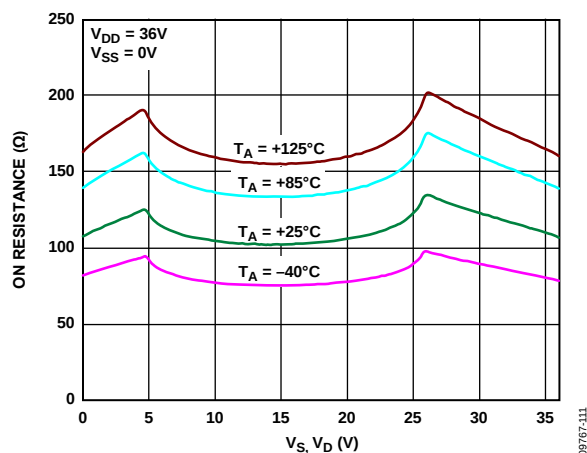


Figure 11. R_{ON} as a Function of V_S , V_D for Different Temperatures, 36 V Single Supply

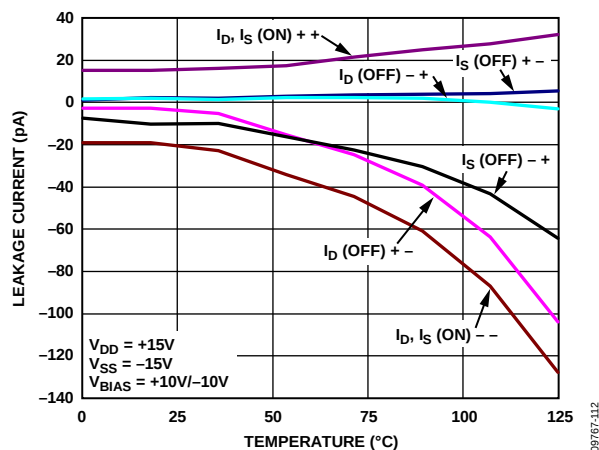


Figure 12. Leakage Currents vs. Temperature, ± 15 V Dual Supply

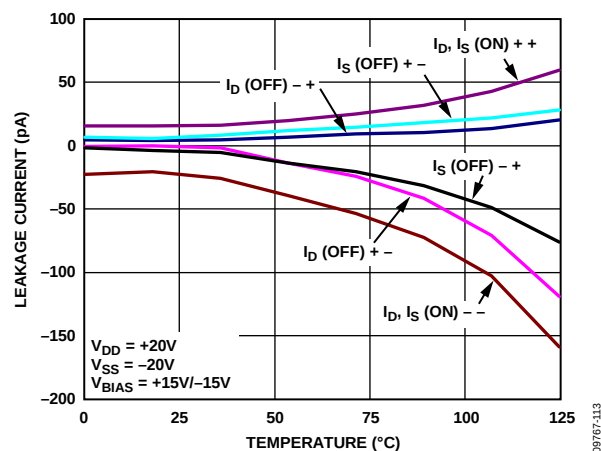


Figure 13. Leakage Currents vs. Temperature, ± 20 V Dual Supply

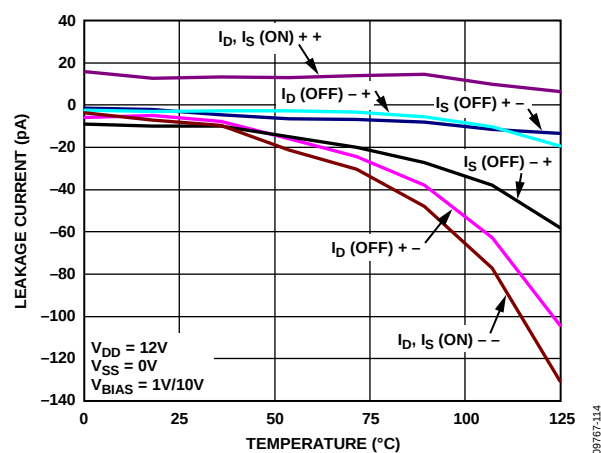


Figure 14. Leakage Currents vs. Temperature, 12 V Single Supply

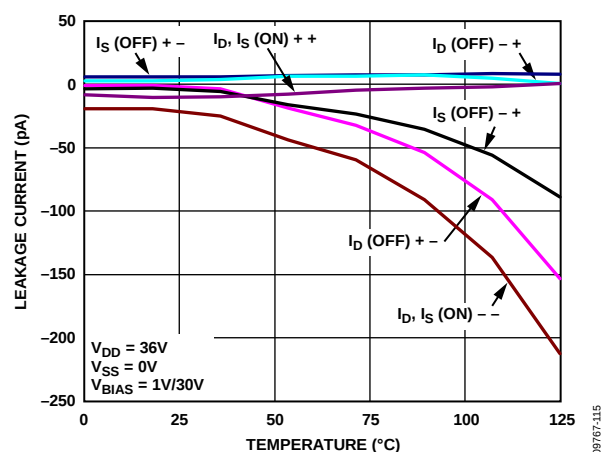


Figure 15. Leakage Currents vs. Temperature, 36 V Single Supply

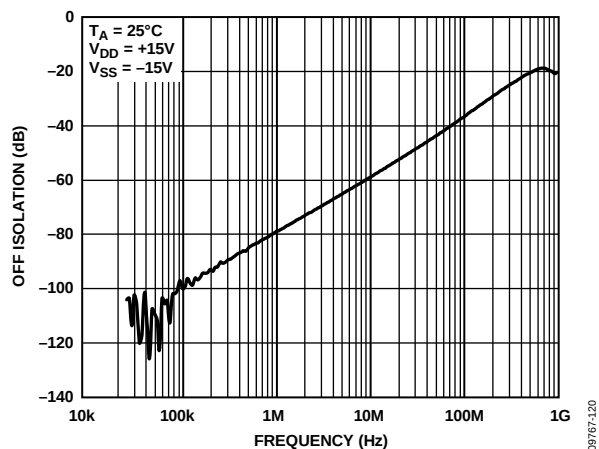


Figure 16. Off Isolation vs. Frequency, ±15 V Dual Supply

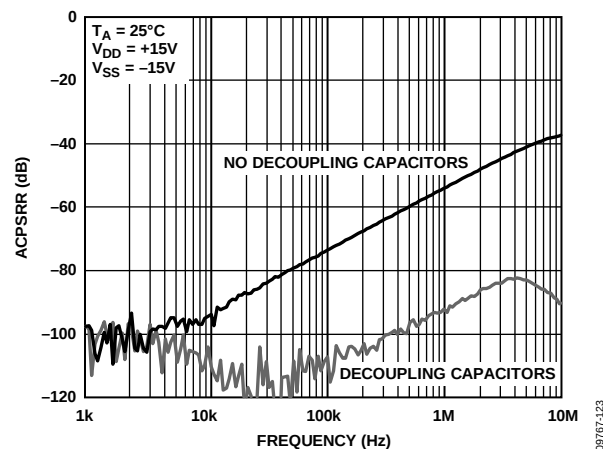


Figure 19. ACPSRR vs. Frequency, ±15 V Dual Supply

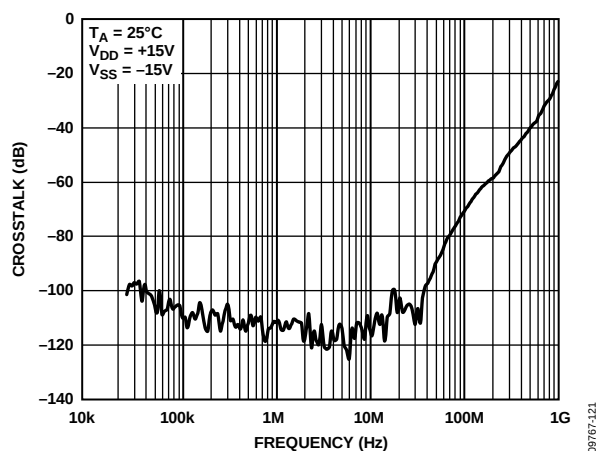


Figure 17. Crosstalk vs. Frequency, ±15 V Dual Supply

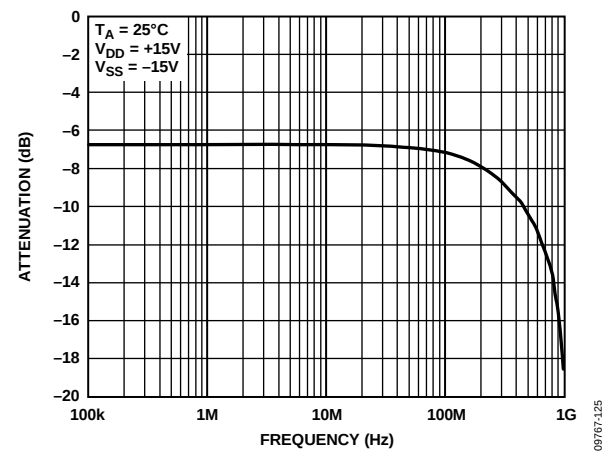


Figure 20. Bandwidth

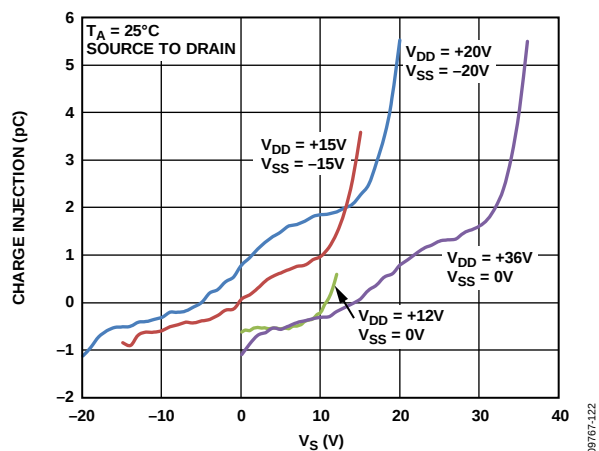


Figure 18. Charge Injection vs. Source Voltage

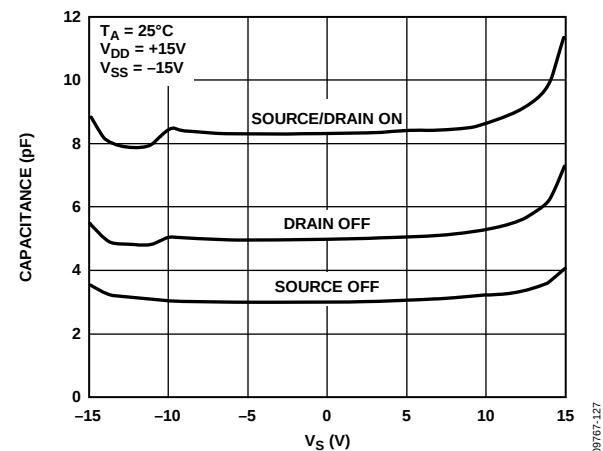


Figure 21. Capacitance

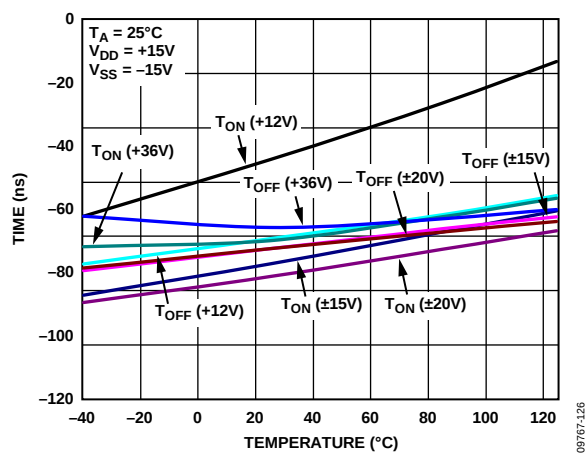


Figure 22. t_{ON} , t_{OFF} Times vs. Temperature

TEST CIRCUITS

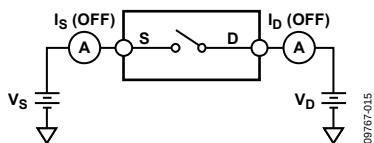


Figure 23. Off Leakage

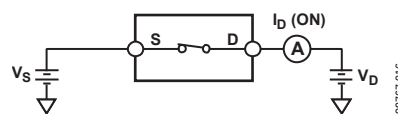


Figure 26. On Leakage

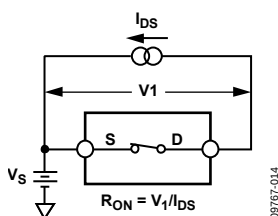


Figure 24. On Resistance

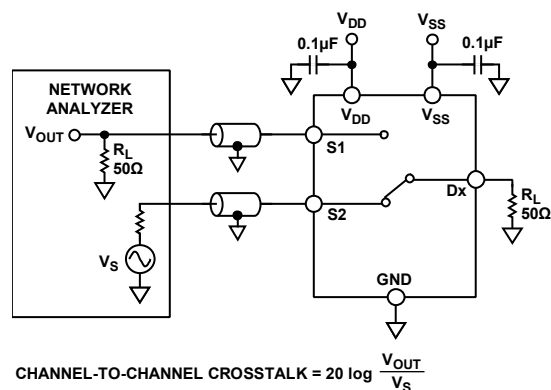


Figure 27. Channel-to-Channel Crosstalk

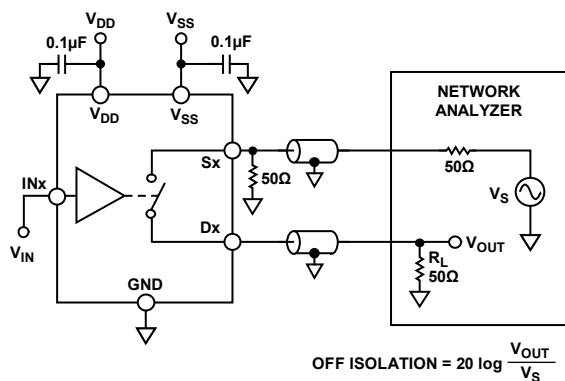


Figure 25. Off Isolation

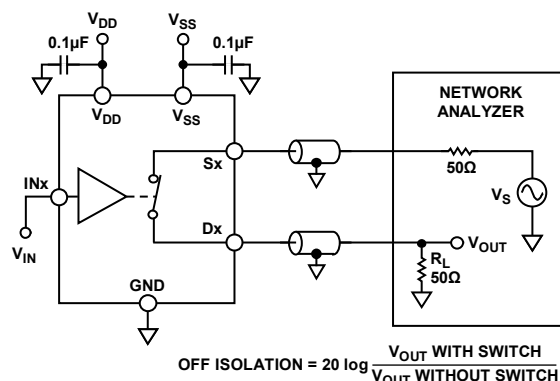


Figure 28. Bandwidth

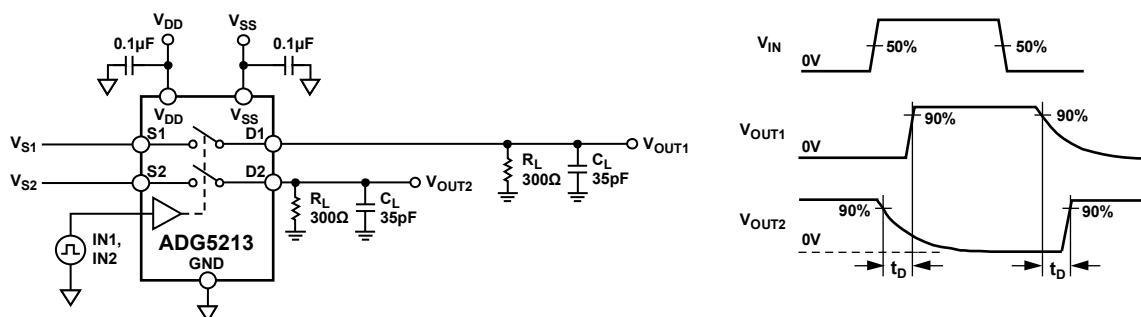
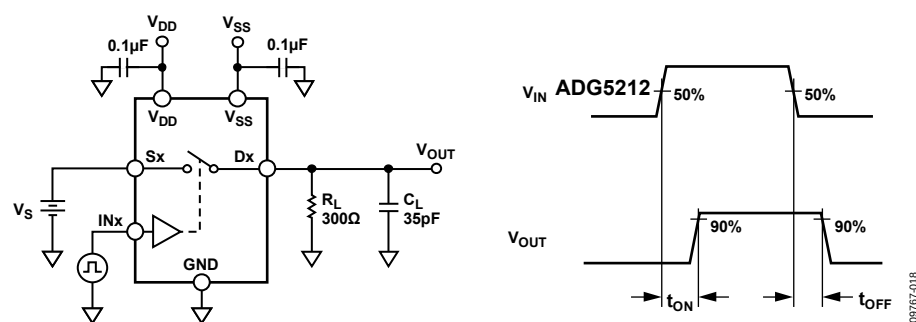
Figure 29. Break-Before-Make Time Delay, t_D 

Figure 30. Switching Times

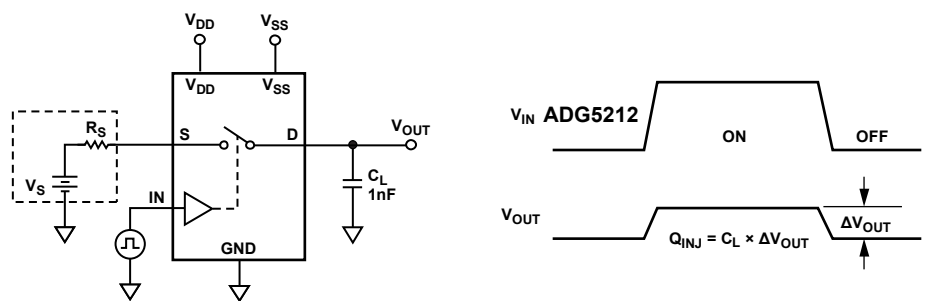


Figure 31. Charge Injection

TERMINOLOGY

I_{DD}

I_{DD} represents the positive supply current.

I_{SS}

I_{SS} represents the negative supply current.

V_D, V_S

V_D and V_S represent the analog voltage on Terminal Dx and Terminal Sx, respectively.

R_{ON}

R_{ON} represents the ohmic resistance between Terminal Dx and Terminal Sx.

ΔR_{ON}

ΔR_{ON} represents the difference between the R_{ON} of any two channels.

$R_{FLAT(ON)}$

Flatness that is defined as the difference between the maximum and minimum value of on resistance measured over the specified analog signal range is represented by $R_{FLAT(ON)}$.

I_S (Off)

I_S (Off) is the source leakage current with the switch off.

I_D (Off)

I_D (Off) is the drain leakage current with the switch off.

I_D (On), I_S (On)

I_D (On) and I_S (On) represent the channel leakage currents with the switch on.

V_{INL}

V_{INL} is the maximum input voltage for Logic 0.

V_{INH}

V_{INH} is the minimum input voltage for Logic 1.

I_{INL}, I_{INH}

I_{INL} and I_{INH} represent the low and high input currents of the digital inputs.

C_D (Off)

C_D (Off) represents the off switch drain capacitance, which is measured with reference to ground.

C_S (Off)

C_S (Off) represents the off switch source capacitance, which is measured with reference to ground.

C_D (On), C_S (On)

C_D (On) and C_S (On) represent on switch capacitances, which are measured with reference to ground.

C_{IN}

C_{IN} is the digital input capacitance.

t_{ON}

t_{ON} represents the delay between applying the digital control input and the output switching on (see Figure 30).

t_{OFF}

t_{OFF} represents the delay between applying the digital control input and the output switching off (see Figure 30).

t_D

t_D represents the off time measured between the 80% point of both switches when switching from one address state to another.

Off Isolation

Off isolation is a measure of unwanted signal coupling through an off switch.

Charge Injection

Charge injection is a measure of the glitch impulse transferred from the digital input to the analog output during switching.

Crosstalk

Crosstalk is a measure of unwanted signal that is coupled through from one channel to another as a result of parasitic capacitance.

Bandwidth

Bandwidth is the frequency at which the output is attenuated by 3 dB.

On Response

On response is the frequency response of the on switch.

Insertion Loss

Insertion loss is the loss due to the on resistance of the switch.

AC Power Supply Rejection Ratio (ACPSRR)

AC power supply rejection ratio (ACPSRR) is the ratio of the amplitude of signal on the output to the amplitude of the modulation. This is a measure of the ability of the device to avoid coupling noise and spurious signals that appear on the supply voltage pin to the output of the switch. The dc voltage on the device is modulated by a sine wave of 0.62 V p-p.

TRENCH ISOLATION

In the [ADG5212](#) and [ADG5213](#), an insulating oxide layer (trench) is placed between the NMOS and the PMOS transistors of each CMOS switch. Parasitic junctions, which occur between the transistors in junction isolated switches, are eliminated, and the result is a completely latch-up proof switch.

In junction isolation, the N and P wells of the PMOS and NMOS transistors form a diode that is reverse-biased under normal operation. However, during overvoltage conditions, this diode can become forward-biased. A silicon controlled rectifier (SCR) type circuit is formed by the two transistors, causing a significant amplification of the current that, in turn, leads to latch-up. With trench isolation, this diode is removed and the result is a latch-up proof switch.

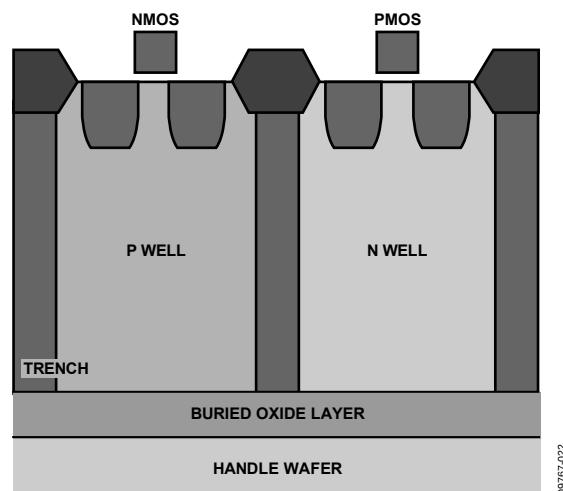


Figure 32. Trench Isolation

APPLICATIONS INFORMATION

The high voltage latch-up proof family of switches and multiplexers provides a robust solution for instrumentation, industrial, automotive, aerospace, and other harsh environments that are prone to latch-up, which is an undesirable high current state that can lead to device failure and persists until the power supply is turned off. The [ADG5212/ADG5213](#) high voltage switches allow single-supply operation from 9 V to 40 V and dual-supply operation from ± 9 V to ± 22 V.

OUTLINE DIMENSIONS

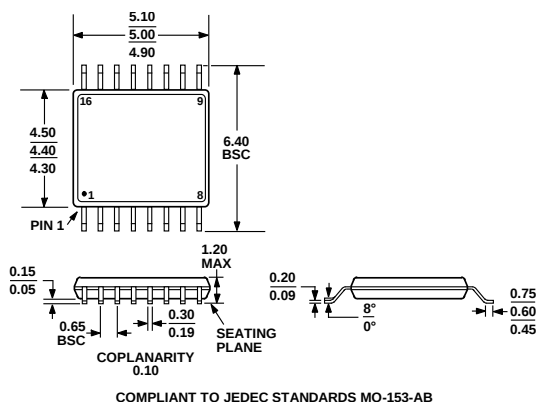
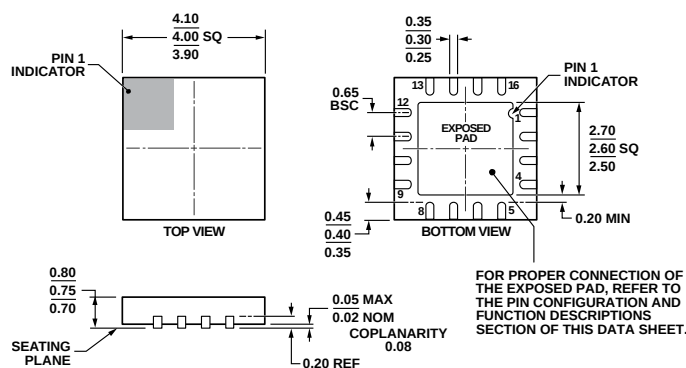


Figure 33. 16-Lead Thin Shrink Small Outline Package [TSSOP]
(RU-16)

Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-220-WGGC.

Figure 34. 16-Lead Lead Frame Chip Scale Package [LFCSP_WQ]
4 mm × 4 mm Body, Very Very Thin Quad
(CP-16-17)

Dimensions shown in millimeters

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
ADG5212BRUZ	−40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG5212BRUZ-RL7	−40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG5212BCPZ-RL7	−40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP_WQ]	CP-16-17
ADG5213BRUZ	−40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG5213BRUZ-RL7	−40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG5213BCPZ-RL7	−40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP_WQ]	CP-16-17

¹ Z = RoHS Compliant Part.

NOTES